
802.3ck D1.3
MTF IL and RL Comments
#122,#22,#178,#123 ,#21 and #269

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Purpose

- **Comments #122, #22,#178,#123 and #21**
 - **Specify MTF ERL requirement**
 - **MTF RL limit informative**
 - **Changes to MTF IL normative limit and RL informative limit**

CI 162B SC 162B.1.3.2 P 256 L 41 # 123
 Kocsis, Sam Amphenol
 Comment Type **TR** Comment Status **X**
 Add definition of ERL for MTF
 SuggestedRemedy
 Copy Table 120G-4, change Tfx to "0", use as reference for MTF ERL
 Proposed Response Response Status **O**

CI 162B SC 162B.1.3.2 P 256 L 40 # 178
 Haser, Alex Molex
 Comment Type **TR** Comment Status **X**
 Current RL mask doesn't accurately capture necessary RL performance
 SuggestedRemedy
 Remove RL mask and replace with ERL ; input values and ERL limit TBD
 Proposed Response Response Status **O**

CI 162B SC 162B.1.3.1 P 255 L 35 # 21
 DiMinico, Christopher MC Communications
 Comment Type **TR** Comment Status **D** MTF IL
 Modify Equation (162B-3) ILMTFMAX > 40 GHz to align with achievable MTF insertion loss
 SuggestedRemedy
 See supporting presentation diminico_3ck_1020.pdf
 Proposed Response Response Status **W**
 PROPOSED ACCEPT IN PRINCIPLE.
 Modify Equation (162B-3) ILMTFMAX > 40 GHz to align with achievable MTF insertion loss
 See slide 11 supporting presentation
https://www.ieee802.org/3/ck/public/20_10/diminico_3ck_01_1020.pdf
 For task force discussion of cited presentation.

CI 162B SC 162B.1.3.2 P 256 L 41 # 122
 Kocsis, Sam Amphenol
 Comment Type **TR** Comment Status **D** MTF RL
 text says test fixture "shall meet" Eq 162B-6
 SuggestedRemedy
 Change to "is recommended to meet and shall meet an ERL of 8dB, see background/consensus presentation
 Proposed Response Response Status **W**
 PROPOSED ACCEPT IN PRINCIPLE.
 Change 162B.1.3.2 from "shall" to "is recommended".
 Modify equation 162B-6 per comment#22.
 Add subclause for MTF ERL with 8 dB requirement.
 Add Table similar 120G-4 with Tfx to "0" to use as reference for MTF ERL.
 Editorial license.
 For task force discussion of cited presentation.
 [Editor's note: Add presentation URL.]

CI 162B SC 162B.1.3.2 P 256 L 46 # 22
 DiMinico, Christopher MC Communications
 Comment Type **TR** Comment Status **D** MTF RL
 Modify Equation (162B-6) DRL(f) > 40 GHz to align with achievable MTF return loss
 SuggestedRemedy
 See supporting presentation diminico_3ck_1020.pdf
 Proposed Response Response Status **W**
 PROPOSED ACCEPT IN PRINCIPLE.
 Resolve using the response to comment #122.

Suppoters

- **Sam Kocsis - Amphenol**
- **Alex Haser - Molex**
- **Rich Mellitz - Samtec**
- **Jane Lim, Upen Reddy Kareti – Cisco**
- **Nathan Tracy, Bruce Champion, TE**

Test Fixtures Specifications (#122,#22,#178,#123 and #21)

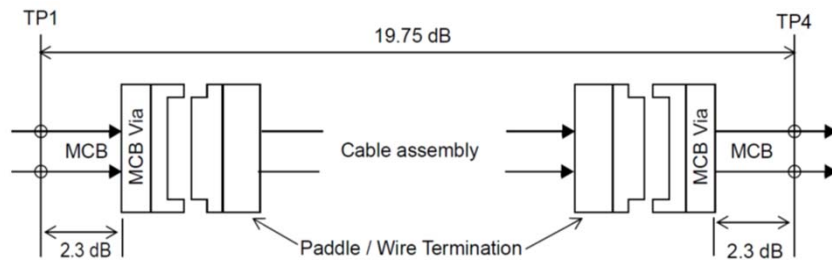
- **RL**
 - **Specify MTF ERL as requirement**
 - **MTF RL limit informative**
 - **Use ERL to assess RL informative limit > 40 GHz**
- **IL**
 - **Use C2M EH and VEC to assess IL normative limit > 40 GHz**

Annex 162B Test Fixtures

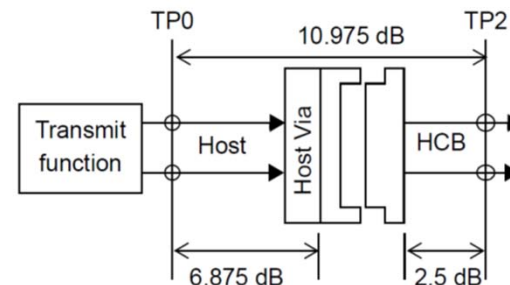
- Test fixtures used separably; MCB for cable assembly/module, HCB for Host.
 - Specified in a mated state (MTF)
- MTF IL, MCB IL, and HCB IL constrained by channel budget.
- All other MTF specifications measurement based.
- **The MTF requirements are not the MDI connector specifications for an implemented design.**

MCB – CR Cable Assembly Test Fixture

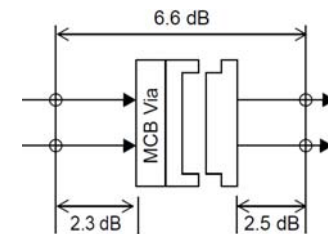
Note compliant OSFP and QSFP-DD cable assemblies posted



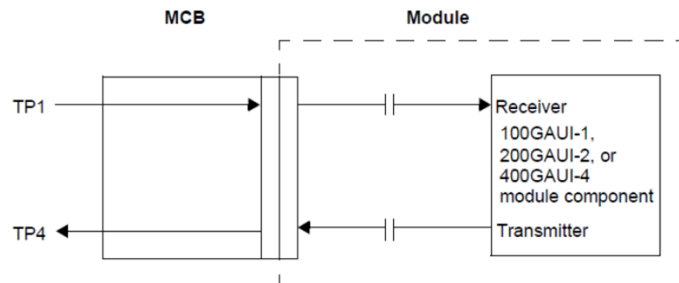
HCB – CR TP2 or TP3 Test Fixture



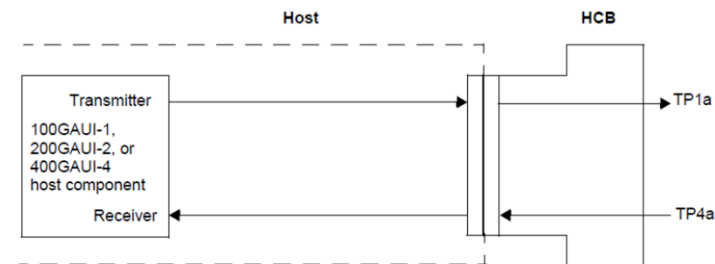
Mated MCB/HCB



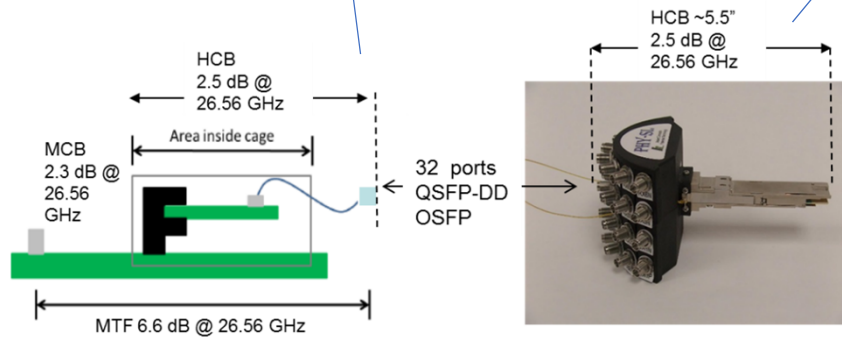
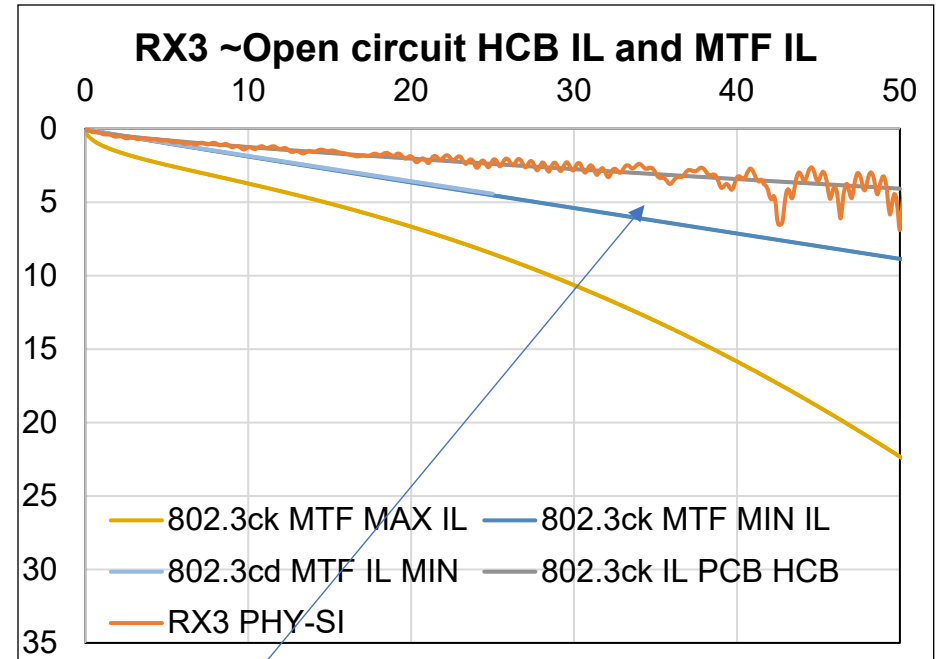
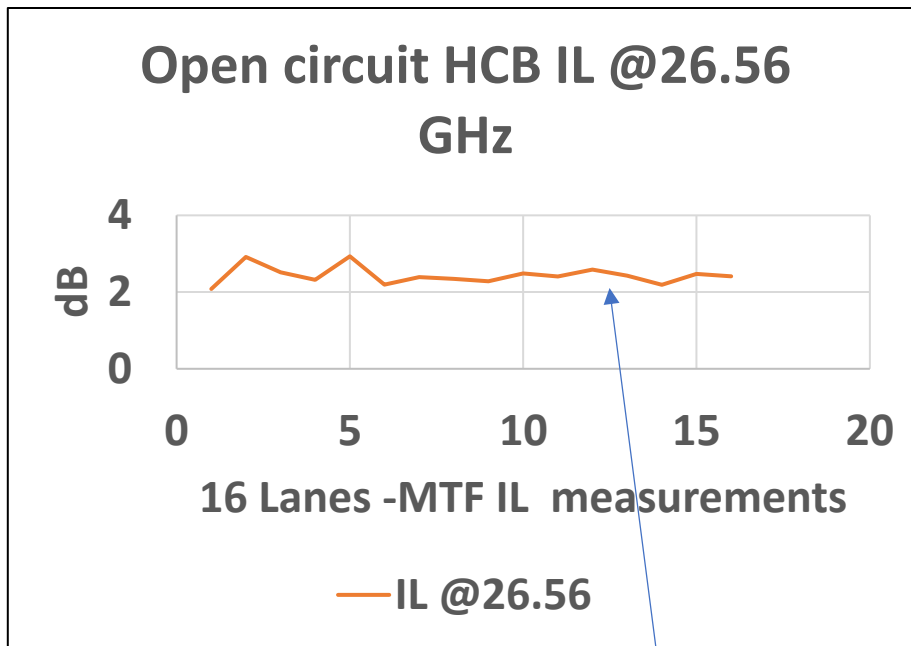
MCB – 120G—Module compliance points



HCB – 120G—Host compliance points



HCB – Test Methods without MCB



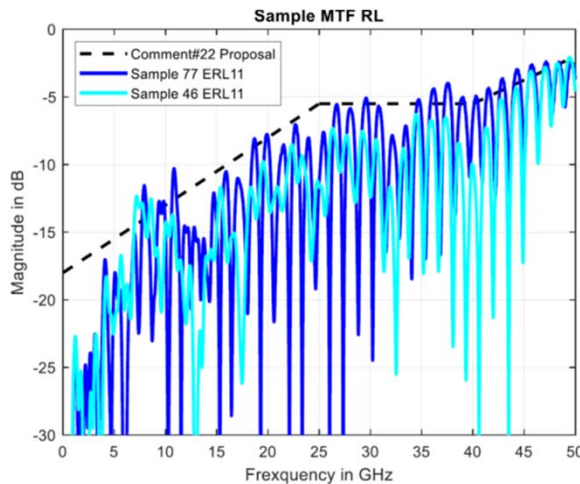
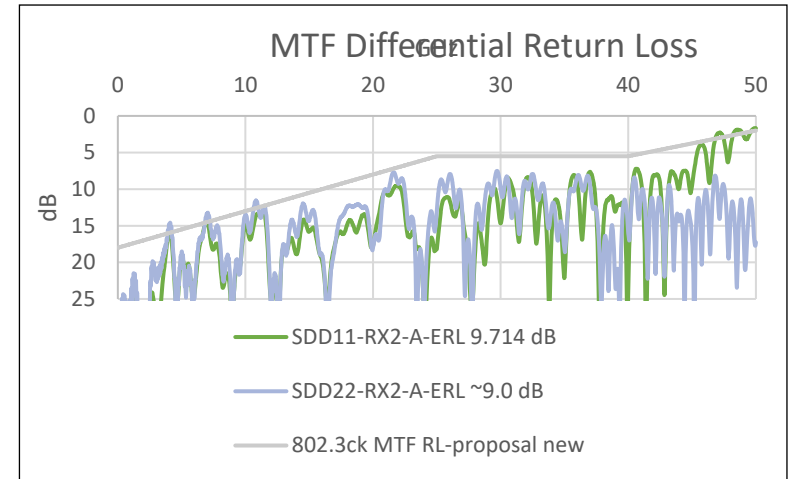
MTF ERL- comment#122,#123,#178

- Specify MTF ERL with 9 dB requirement
- Use MTF ERL Parameters Table Below

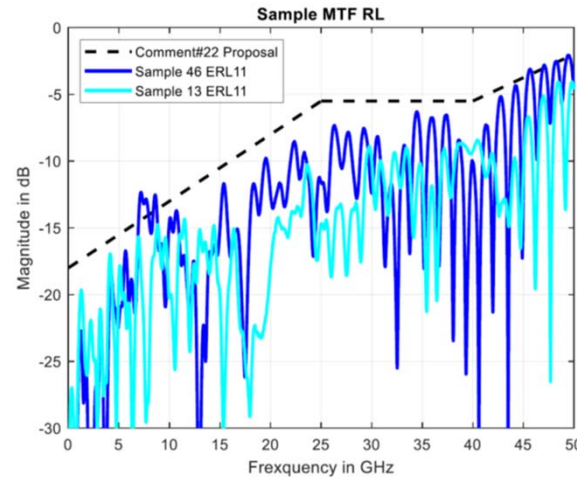
Parameter	Symbol	Value	Units
Transition time associated with a pulse	T_r	0.01	ns
Incremental available signal loss factor	β_x	0	GHz
Permitted reflection from a transmission line external to the device under test	ρ_x	0.618	—
Length of the reflection signal	N	400	UI
Equalizer length associated with reflection signal	N_{eq}	0	UI
Twice the propagation delay associated with the test fixture	T_{fx}	0	ns
Tukey window flag	r_w	1	—

config_com_ieee8023_93a=3ck_d1p3_120g_C2M_tp1a_09_01_20

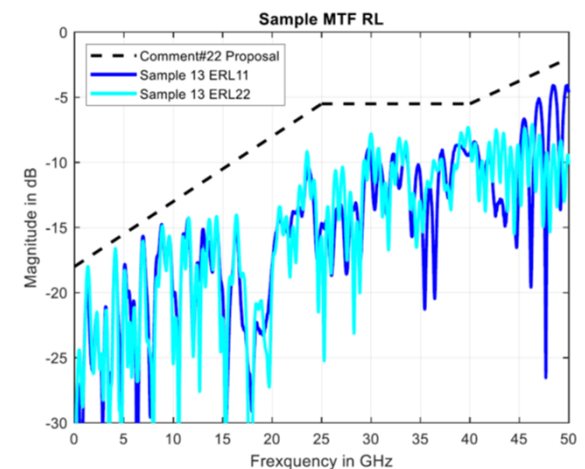
TDR_W_TXPKG	0	
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Shown difference between ERL ~7dB and ERL ~8dB



Shown difference between ERL ~8dB and ERL ~10dB



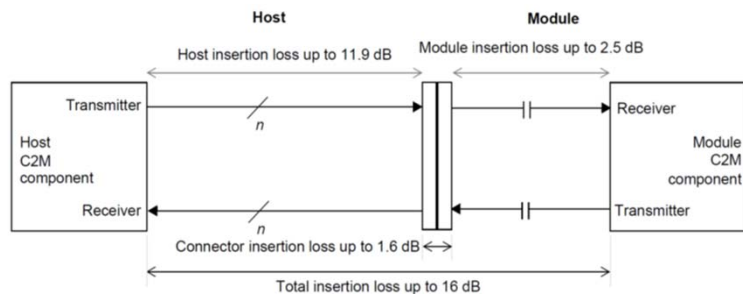
The difference caused by the limit line violation >45GHz is ~0.2dB ERL

https://www.ieee802.org/3/ck/public/20_10/kocsis_3ck_02b_1020.pdf

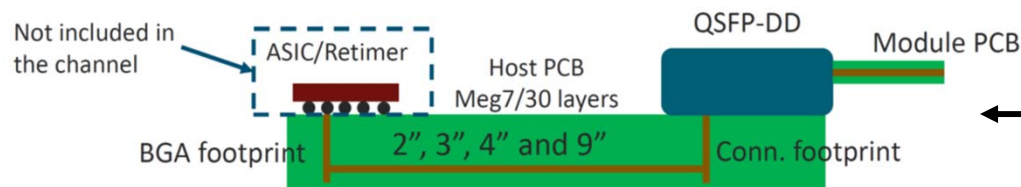
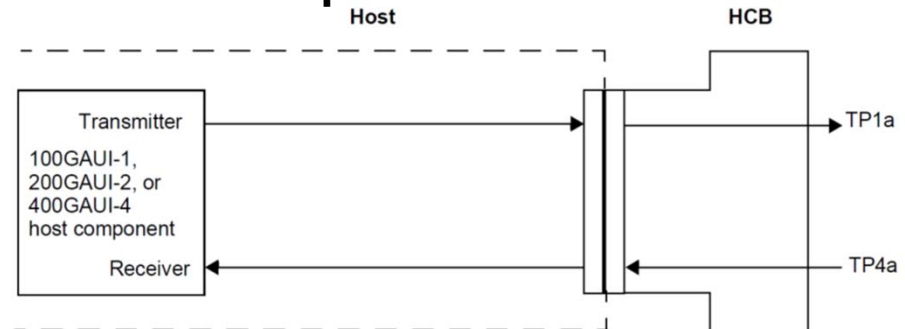
Chip to Module Configuration

- `com_ieee8023_93a_295`
- `config_com_ieee8023_93a=3ck_d1p3_120g_C2M_tp1a_09_01_20`

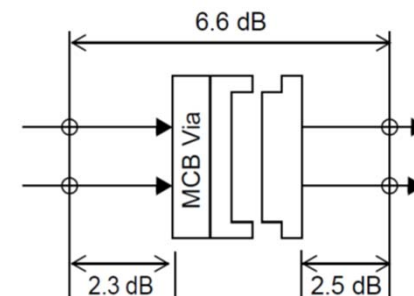
Chip to Module



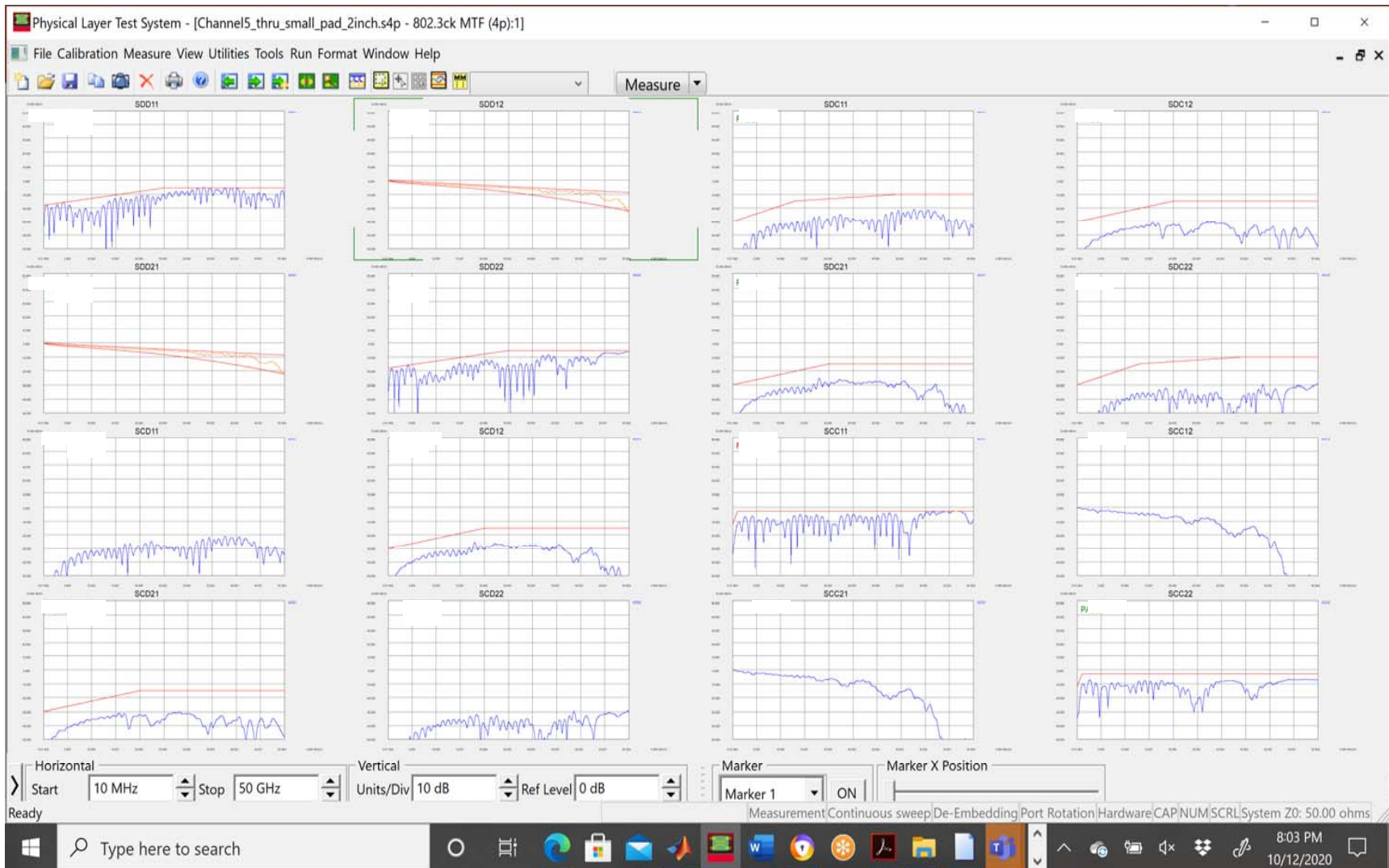
Host Compliance Points



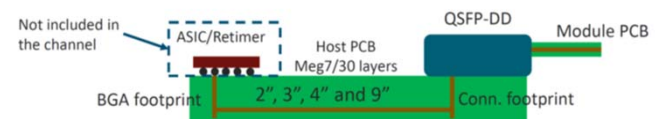
Note stripline trace launch expected ERL >30.



C2M measurements – MTF limits

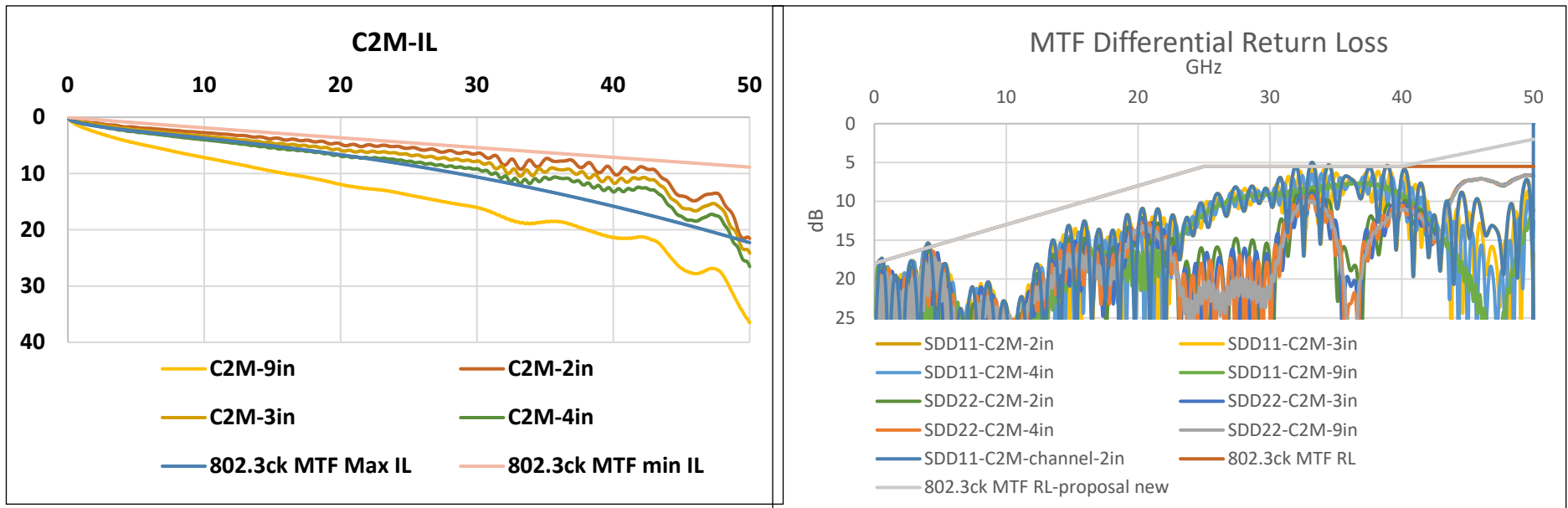


- C2M Channel5_thru_small_pad_2inch.s4p
 Note stripline trace launch expected ERL >30.



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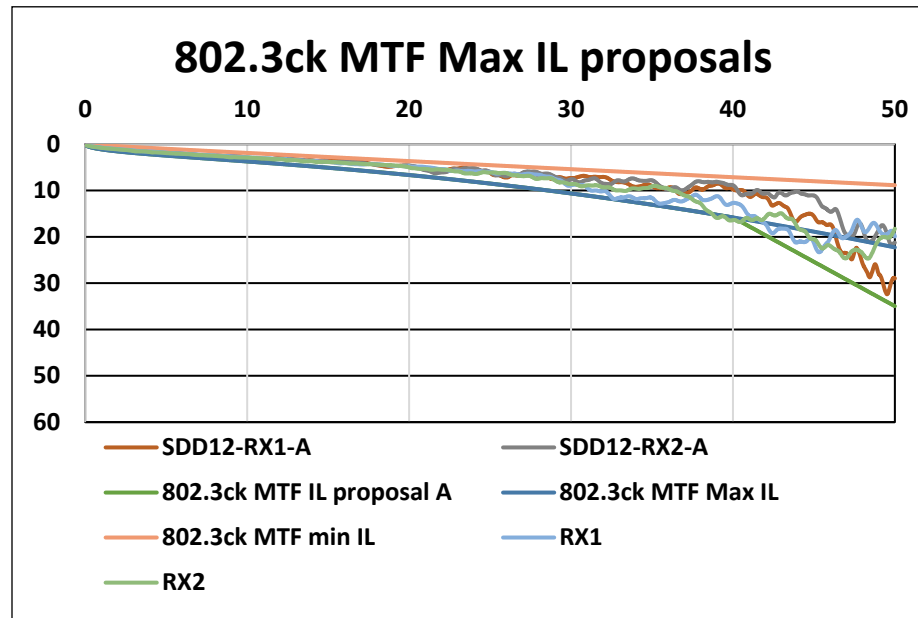
C2M measurements – MTF limits-EH-VEC-ERL



C2M-Topology/COM setting	VEC (dB)	EH (mV)	ERL 22 (dB)	ERL 11 (dB)
C2M-2in - TDR PKG ON	8.117	32.232	8.976	9.138
C2M-3in - TDR PKG ON	8.164	30.721	9.484	9.507
C2M-4in - TDR PKG ON	7.747	26.753	9.951	9.805
C2M-9in - TDR PKG ON	7.817	15.169	11.379	10.912
C2M-Topology/COM setting	VEC (dB)	EH (mV)	ERL 22 (dB)	ERL 11 (dB)
C2M-2in - TDR PKG OFF	8.177	32.232	11.305	9.139
C2M-3in - TDR PKG OFF	8.164	30.721	11.424	9.507
C2M-4in - TDR PKG OFF	7.747	26.753	11.548	9.805
C2M-9in - TDR PKG OFF	7.817	15.169	11.9651	10.912

Note stripline trace launch expected ERL >30.

MTF IL proposal- comment#21



$$\text{MTF IL proposal A} = 1.185 \cdot \text{SQRT}(f) - 0.072 \cdot f + 0.007 \cdot f^2 \quad 0.01 \text{ GHz} \leq f < 40 \text{ GHz}$$

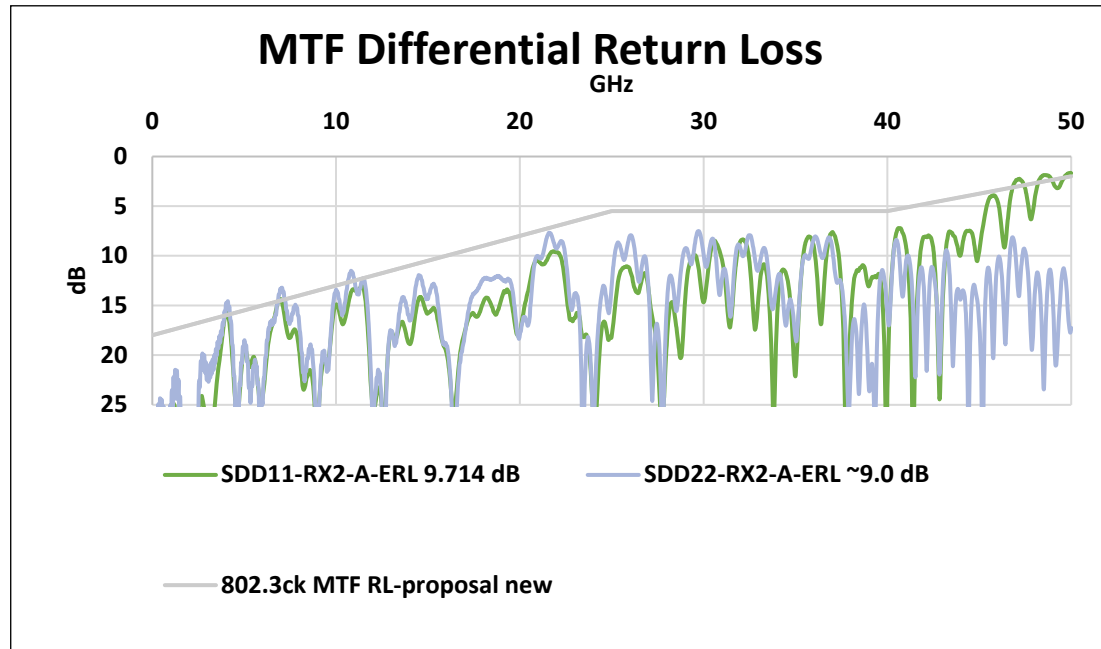
$$\text{MTF IL proposal A} = 1.915 \cdot f - 60.78 \quad 40 \text{ GHz} \leq f \leq 50 \text{ GHz}$$

RX1-TDR PKG OFF
VEC = 7.975 dB
EH = 33.915 mV
ERL = 11.172 dB (11.318 dB, 11.172 dB)
RX2-TDR PKG OFF
VEC = 7.840 dB
EH = 32.138 mV
ERL = 10.710 dB (10.912 dB, 10.710 dB)

RX1-A TDR OFF
VEC = 8.496 dB
EH = 32.737 mV
ERL = 8.336 dB (9.218 dB, 8.336 dB)
RX2-A TDR OFF
VEC = 8.378 dB
EH = 31.549 mV
ERL = 9.069 dB (9.714 dB, 9.069 dB)

C2M-Topology/COM setting	VEC (dB)	EH (mV)
C2M-2in - TDR PKG OFF	8.177	32.232
C2M-3in - TDR PKG OFF	8.164	30.721
C2M-4in - TDR PKG OFF	7.747	26.753
C2M-9in - TDR PKG OFF	7.817	15.169

MTF RL comment#22



- MTF RL limit informative
- Change RL limit > 40 GHz

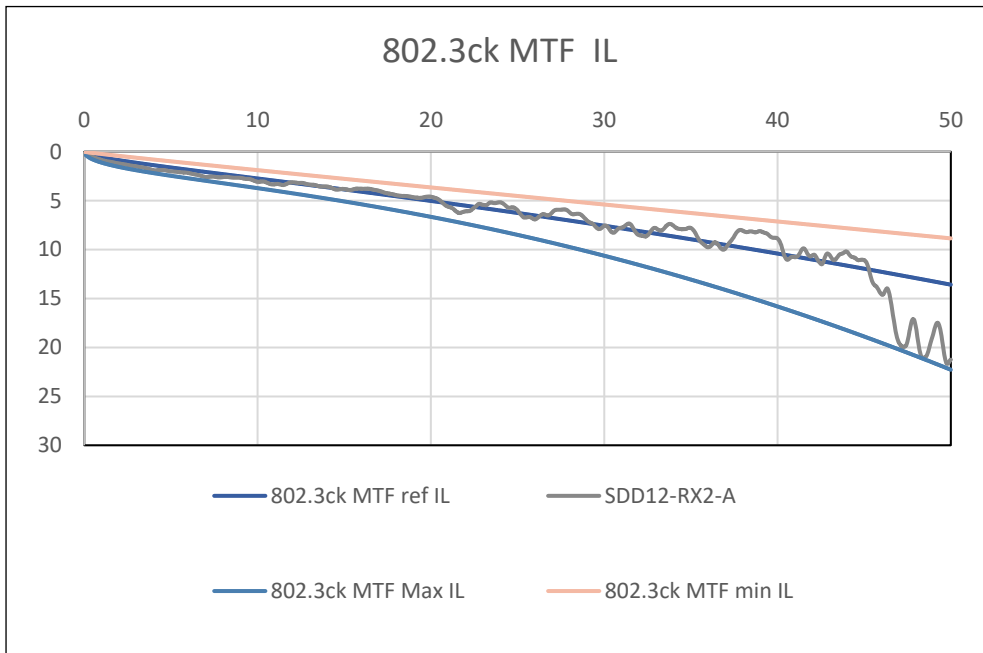
PROPOSAL: Differential Return Loss =

$$18 - 0.5 * f_{\text{GHz}} \quad 0.05 \text{ GHz} \leq f_{\text{GHz}} < 25 \text{ GHz}$$

$$5.5 \quad 25 \text{ GHz} \leq f_{\text{GHz}} < 40 \text{ GHz}$$

$$-.35 * (f_{\text{GHz}} - 40) + 5.5 \quad 40 \text{ GHz} \leq f_{\text{GHz}} \leq 50 \text{ GHz}$$

MTF IL comment#269



162B.1.2.1 Cable assembly test fixture insertion loss
 The cable assembly test fixture printed circuit board and test point insertion loss values determined using Equation (162B-2) shall be used as the reference test fixture insertion loss. The effects of differences between the insertion loss of an actual test fixture and the reference insertion loss are to be accounted for in the measurements.

The reference insertion loss of the mated test fixture is determined using Equation (162B-5).

$$IL_{MatedTF}(f) = 0.9502(0.471\sqrt{f} + 0.1194f + 0.002f^2) \quad (162B-5)$$

for $0.01 \text{ GHz} \leq f \leq 50 \text{ GHz}$

where

$IL_{MatedTF}(f)$ is the reference insertion loss of the mated test fixture insertion loss in dB at frequency f

f is the frequency in GHz

Proposed response: AIP
 Change upper frequency EQ: 162B-5 to 30 GHz. Plot MTF reference IL Figure 162B-3.

CI 162B SC 162B.1.3.1 P 256 L 12 # 269

Dawe, Piers Nvidia MTF IL

Comment Type E Comment Status D

Figure 162B-3, Mated test fixtures insertion loss, shows the maximum and minimum IL but not the reference IL.

SuggestedRemedy

Please show the reference insertion loss of the mated test fixture also, on the same graph.

Proposed Response Response Status W

PROPOSED REJECT.

The reference IL does not include ILD and therefore not representative of MTF IL i.e, as a reference over frequency.

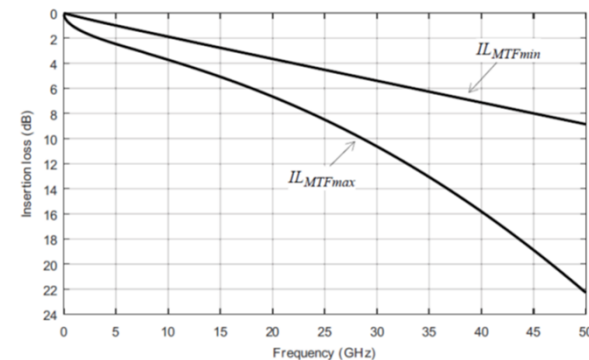


Figure 162B-3—Mated test fixtures insertion loss